

General Description

BXP3N50 is Bridgelux high voltage MOSFET family based on advanced planar DMOS technology. This advanced MOSFET family has optimized on-state resistance, and also provides superior switching performance and higher avalanche energy strength. This device family is suitable for high efficiency switch mode power supplies.

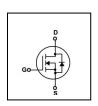
FEATURES

- RDSON \leq 3 Ω @Vgs=10V, Id=2A
- Excellent RDS(ON) and Low Gate Charge

Version: 1.0

- · Fast switching capability
- Lead free product is acquired

SYMBOL





TO-251L TO-252 TO-220 TO-220F

ASSEMBLY MESSAGE

Product Name	Package	Packaging	
BXP3N50U	TO-251L	Tube	
BXP3N50D	TO-252	Tube/Reel	
BXP3N50P	TO-220	Tube	
BXP3N50F	TO-220F	TO-220F Tube	

ABSOLUTE MAXIMUM RATINGS (T_C=25°C unless otherwise noted)

Parameter		Symbol	Rating			
			BXP3N50U/D	BXP3N50P	BXP3N50F	- Unit
Drain-Source Voltage		V _{DSS}	500			V
Drain Current	Continuous (T _C = 25°C)		3			Α
	Continuous (T _C = 100°C)	l _D	1.8			Α
Drain Current Pulsed (Note1)		I _{DM}	12			Α
Gate-Source Voltage		V _{GSS}	±30			V
Avalanche Energy Single Pulse (Note2)		E _{AS}	80			mJ
Avalanche Current (Note1)		I AR	3			Α
Peak Diode Recovery dv/dt (Note3)		dv/dt	5			V/ns
D D: : (: () () ()	T _C =25°C	- P _D	50	60	25	W
Power Dissipation (Note 2)	Derate above 25°C		0.4	0.48	0.2	W/°C
Maximum Junction Temperature		TJ	150			°C
Storage Temperature Range		T _{STG}	-55 to 150			°C

Note:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L=10mH, V_{DD} =50V, RG=25 Ω , Starting TJ = 25°C
- 3. $I_{SD} \le 3.0A$, di/dt $\le 100A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting TJ = 25°C



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THERMAL CHARACTERISTICS

Parameter	Symbol		l lmi4		
Farameter		BXP3N50U/D	BXP3N50P	BXP3N50F	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	2.5	2.08	5	°C/W
Thermal Resistance, Junction-to-Ambient	R _{0JA}	100	62.5	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_J=25°C,unless otherwise Noted)

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS	'			•		•
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V, ID=250µA	500			V
7 0 1 1/1 5 1 0 1	I _{DSS}	VDS=500V, VGS=0V			1	uA
Zero Gate Voltage Drain Current		VDS=400V, TC = 125°C			100	uA
Gate-Body Leakage Current, Forward		VGS=30V			100	nA
Gate-Body Leakage Current, Reverse	- I _{GSS}	VGS=-30V			-100	nA
Breakdown Voltage Temperature	△BVDSS/	ID = 250A		0.6		V/℃
Coefficient	△TJ	ID = 250 μA		0.0		V / C
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS(TH)}}$	VDS=VGS, ID=250μA	2		4	V
Drain-Source On-State Resistance	R _{DS(ON)}	VGS=10V, ID=1.5A		2.6	3	Ω
Forward Transconductance (Note4)	g FS	VDS =20V, ID=1.5A		2.5		S
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}	1/20 02/1/00 01/		320		pF
Output Capacitance	Coss	VDS=25V, VGS=0V,		40		pF
Reverse Transfer Capacitance	C _{RSS}	f=1.0MHz		3.1		pF
SWITCHING PARAMETERS			•			
Turn-ON Delay Time	t _{D(ON)}	\/DD 050\/ ID 04 \/00		10		ns
Turn-ON Rise Time	t _R	VDD=250V, ID=3A, VGS =		15.5		ns
Turn-OFF Delay Time	t _{D(OFF)}	10V ,RG=10Ω		32		ns
Turn-OFF Fall-Time	t⊧	(Note4,5)		10		ns
Total Gate Charge(Note5)	Q_{G}	VDS =400V, VGS =10V, ID		9		nC
Gate Source Charge	Q _{GS}	=3A		1.6		nC
Gate Drain Charge	Q_{GD}	(Note4,5)		4.5		nC
SOURCE- DRAIN DIODE RATINGS	AND CHARA	CTERISTICS	•			
Drain-Source Diode Forward Voltage	V _{SD}	IS=3A, VGS=0V			1.4	V
Diode Continuous Forward Current	Is				3	Α
Pulsed Drain-Source Current	I _{SM}				12	Α
Reverse Recovery Time	t _{RR}	VGS = 0 V, ISD = 3A		180		ns
Reverse Recovery Charge	Q _{RR}	di/dt=100 A/µs (Note4,5)		0.62		uC

Note: 4. Pulse Test : Pulse width $\leq 300 \mu s$, Duty cycle $\leq 2\%$

^{5.} Essentially independent of operating temperature



TYPICAL CHARACTERISTICS

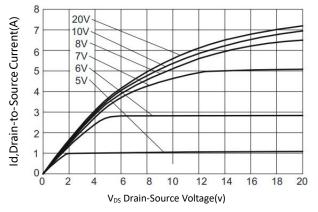


Figure 1. Typical Output Characteristics

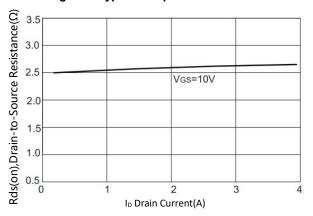


Figure 3. On-Resistance versus Drain Current

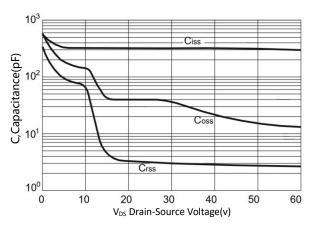


Figure 5. Typical Capacitance versus V_{DS}

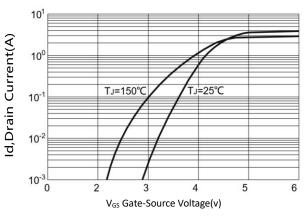


Figure 2. Typical Transfer Characteristics

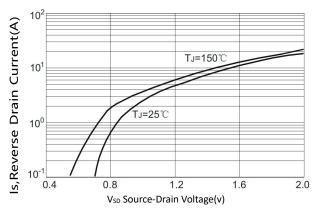


Figure 4. Diode forward voltage versus Current

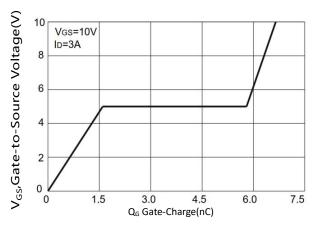


Figure 6. Typical Gate Charge versus V_{GS}



TYPICAL CHARACTERISTICS(Cont.)

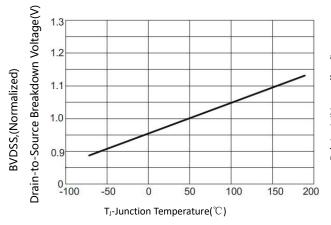


Figure 7. BV_{DSS} Variation with Temperature

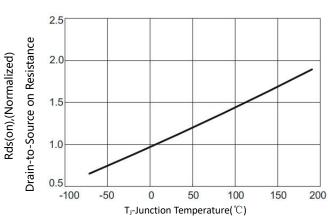


Figure8. On-Resistance Variation with Temperature

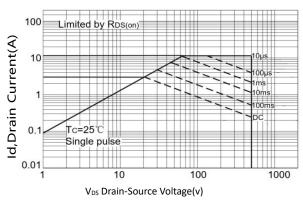


Figure 9. Maximum Safe Operating Area BXP3N50U/D/P

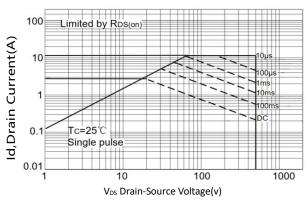


Figure 10. Maximum Safe Operating Area BXP3N50F

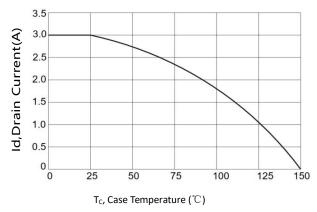
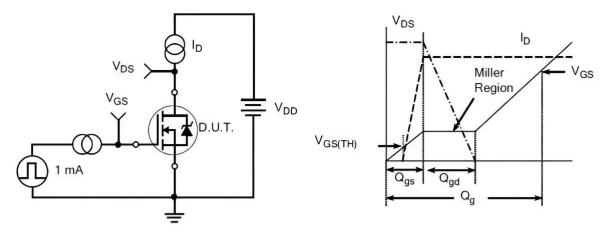


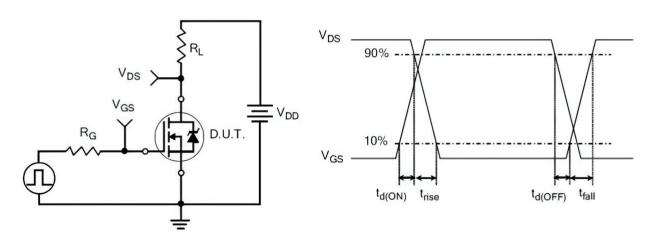
Figure 10. Maximum Continuous Drain Current versus Case Temperature

TEST CIRCUITS AND WAVEFORMS



Gate Charge Test Circuit

Gate Charge Waveform

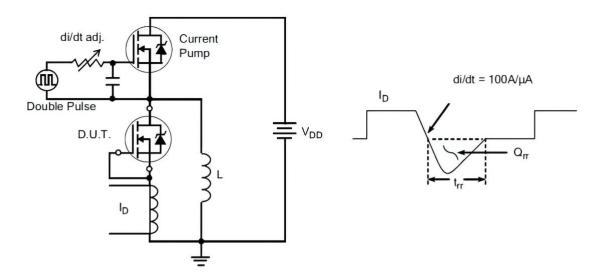


Resistive Switching Test Circuit

Resistive Switching Waveforms

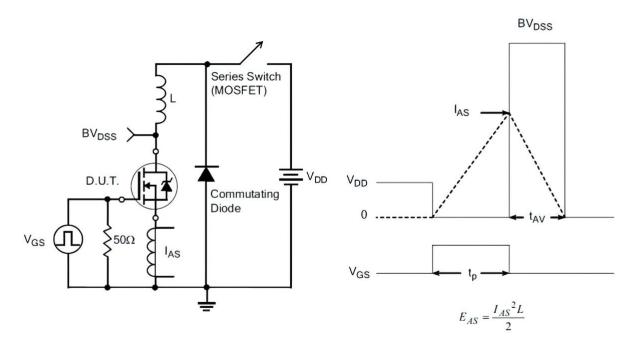


TEST CIRCUITS AND WAVEFORMS(Cont.)



Diode Reverse Recovery Test Circuit

Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms





Revision history

Document revision history

Date	Revision	Changes
15-Nov-2021	1.0	First release



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BXP3N50

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